# E·XFL

## Intel - EP20K300EFC672-1 Datasheet



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#### Understanding <u>Embedded - FPGAs (Field</u> <u>Programmable Gate Array)</u>

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

### **Applications of Embedded - FPGAs**

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications.

## Details

Details	
Product Status	Obsolete
Number of LABs/CLBs	1152
Number of Logic Elements/Cells	11520
Total RAM Bits	147456
Number of I/O	408
Number of Gates	728000
Voltage - Supply	1.71V ~ 1.89V
Mounting Type	Surface Mount
Operating Temperature	0°C ~ 85°C (TJ)
Package / Case	672-BBGA
Supplier Device Package	672-FBGA (27x27)
Purchase URL	https://www.e-xfl.com/product-detail/intel/ep20k300efc672-1

Email: info@E-XFL.COM

Address: Room A, 16/F, Full Win Commercial Centre, 573 Nathan Road, Mongkok, Hong Kong

All APEX 20K devices are reconfigurable and are 100% tested prior to shipment. As a result, test vectors do not have to be generated for fault coverage purposes. Instead, the designer can focus on simulation and design verification. In addition, the designer does not need to manage inventories of different application-specific integrated circuit (ASIC) designs; APEX 20K devices can be configured on the board for the specific functionality required.

APEX 20K devices are configured at system power-up with data stored in an Altera serial configuration device or provided by a system controller. Altera offers in-system programmability (ISP)-capable EPC1, EPC2, and EPC16 configuration devices, which configure APEX 20K devices via a serial data stream. Moreover, APEX 20K devices contain an optimized interface that permits microprocessors to configure APEX 20K devices serially or in parallel, and synchronously or asynchronously. The interface also enables microprocessors to treat APEX 20K devices as memory and configure the device by writing to a virtual memory location, making reconfiguration easy.

After an APEX 20K device has been configured, it can be reconfigured in-circuit by resetting the device and loading new data. Real-time changes can be made during system operation, enabling innovative reconfigurable computing applications.

APEX 20K devices are supported by the Altera Quartus II development system, a single, integrated package that offers HDL and schematic design entry, compilation and logic synthesis, full simulation and worst-case timing analysis, SignalTap logic analysis, and device configuration. The Quartus II software runs on Windows-based PCs, Sun SPARCstations, and HP 9000 Series 700/800 workstations.

The Quartus II software provides NativeLink interfaces to other industrystandard PC- and UNIX workstation-based EDA tools. For example, designers can invoke the Quartus II software from within third-party design tools. Further, the Quartus II software contains built-in optimized synthesis libraries; synthesis tools can use these libraries to optimize designs for APEX 20K devices. For example, the Synopsys Design Compiler library, supplied with the Quartus II development system, includes DesignWare functions optimized for the APEX 20K architecture.

## Functional Description

APEX 20K devices incorporate LUT-based logic, product-term-based logic, and memory into one device. Signal interconnections within APEX 20K devices (as well as to and from device pins) are provided by the FastTrack<sup>®</sup> Interconnect—a series of fast, continuous row and column channels that run the entire length and width of the device.

Each I/O pin is fed by an I/O element (IOE) located at the end of each row and column of the FastTrack Interconnect. Each IOE contains a bidirectional I/O buffer and a register that can be used as either an input or output register to feed input, output, or bidirectional signals. When used with a dedicated clock pin, these registers provide exceptional performance. IOEs provide a variety of features, such as 3.3-V, 64-bit, 66-MHz PCI compliance; JTAG BST support; slew-rate control; and tri-state buffers. APEX 20KE devices offer enhanced I/O support, including support for 1.8-V I/O, 2.5-V I/O, LVCMOS, LVTTL, LVPECL, 3.3-V PCI, PCI-X, LVDS, GTL+, SSTL-2, SSTL-3, HSTL, CTT, and 3.3-V AGP I/O standards.

The ESB can implement a variety of memory functions, including CAM, RAM, dual-port RAM, ROM, and FIFO functions. Embedding the memory directly into the die improves performance and reduces die area compared to distributed-RAM implementations. Moreover, the abundance of cascadable ESBs ensures that the APEX 20K device can implement multiple wide memory blocks for high-density designs. The ESB's high speed ensures it can implement small memory blocks without any speed penalty. The abundance of ESBs ensures that designers can create as many different-sized memory blocks as the system requires. Figure 1 shows an overview of the APEX 20K device.



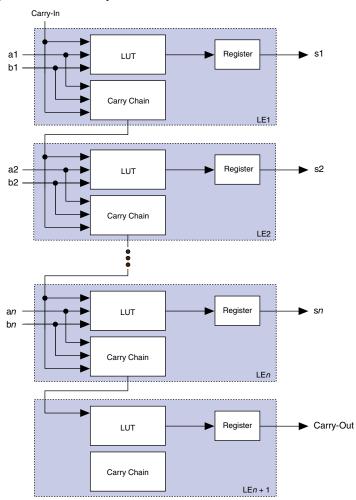


Figure 6. APEX 20K Carry Chain

The counter mode uses two three-input LUTs: one generates the counter data, and the other generates the fast carry bit. A 2-to-1 multiplexer provides synchronous loading, and another AND gate provides synchronous clearing. If the cascade function is used by an LE in counter mode, the synchronous clear or load overrides any signal carried on the cascade chain. The synchronous clear overrides the synchronous load. LEs in arithmetic mode can drive out registered and unregistered versions of the LUT output.

## Clear & Preset Logic Control

Logic for the register's clear and preset signals is controlled by LAB-wide signals. The LE directly supports an asynchronous clear function. The Quartus II software Compiler can use a NOT-gate push-back technique to emulate an asynchronous preset. Moreover, the Quartus II software Compiler can use a programmable NOT-gate push-back technique to emulate simultaneous preset and clear or asynchronous load. However, this technique uses three additional LEs per register. All emulation is performed automatically when the design is compiled. Registers that emulate simultaneous preset and load will enter an unknown state upon power-up or when the chip-wide reset is asserted.

In addition to the two clear and preset modes, APEX 20K devices provide a chip-wide reset pin (DEV\_CLRn) that resets all registers in the device. Use of this pin is controlled through an option in the Quartus II software that is set before compilation. The chip-wide reset overrides all other control signals. Registers using an asynchronous preset are preset when the chip-wide reset is asserted; this effect results from the inversion technique used to implement the asynchronous preset.

## FastTrack Interconnect

In the APEX 20K architecture, connections between LEs, ESBs, and I/O pins are provided by the FastTrack Interconnect. The FastTrack Interconnect is a series of continuous horizontal and vertical routing channels that traverse the device. This global routing structure provides predictable performance, even in complex designs. In contrast, the segmented routing in FPGAs requires switch matrices to connect a variable number of routing paths, increasing the delays between logic resources and reducing performance.

The FastTrack Interconnect consists of row and column interconnect channels that span the entire device. The row interconnect routes signals throughout a row of MegaLAB structures; the column interconnect routes signals throughout a column of MegaLAB structures. When using the row and column interconnect, an LE, IOE, or ESB can drive any other LE, IOE, or ESB in a device. See Figure 9.

The programmable register also supports an asynchronous clear function. Within the ESB, two asynchronous clears are generated from global signals and the local interconnect. Each macrocell can either choose between the two asynchronous clear signals or choose to not be cleared. Either of the two clear signals can be inverted within the ESB. Figure 15 shows the ESB control logic when implementing product-terms.

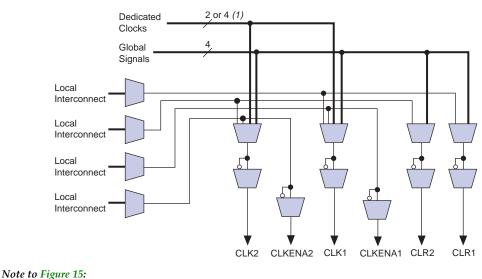


Figure 15. ESB Product-Term Mode Control Logic

(1) APEX 20KE devices have four dedicated clocks.

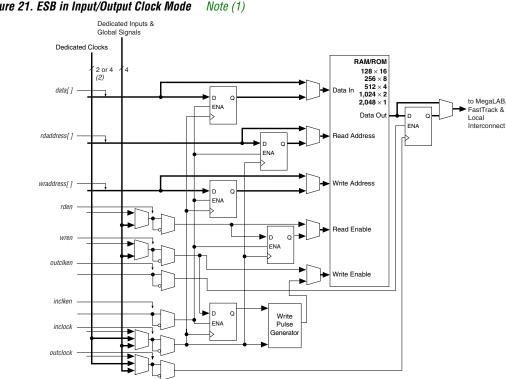
## Parallel Expanders

Parallel expanders are unused product terms that can be allocated to a neighboring macrocell to implement fast, complex logic functions. Parallel expanders allow up to 32 product terms to feed the macrocell OR logic directly, with two product terms provided by the macrocell and 30 parallel expanders provided by the neighboring macrocells in the ESB.

The Quartus II software Compiler can allocate up to 15 sets of up to two parallel expanders per set to the macrocells automatically. Each set of two parallel expanders incurs a small, incremental timing delay. Figure 16 shows the APEX 20K parallel expanders.

## Input/Output Clock Mode

The input/output clock mode contains two clocks. One clock controls all registers for inputs into the ESB: data input, WE, RE, read address, and write address. The other clock controls the ESB data output registers. The ESB also supports clock enable and asynchronous clear signals; these signals also control the reading and writing of registers independently. Input/output clock mode is commonly used for applications where the reads and writes occur at the same system frequency, but require different clock enable signals for the input and output registers. Figure 21 shows the ESB in input/output clock mode.



#### Figure 21. ESB in Input/Output Clock Mode

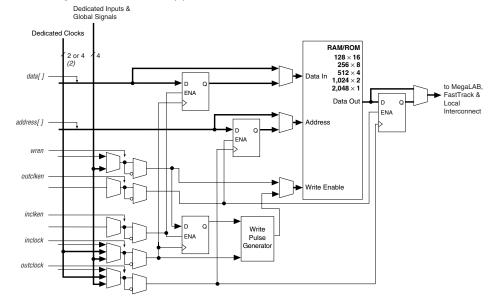
#### Notes to Figure 21:

All registers can be cleared asynchronously by ESB local interconnect signals, global signals, or the chip-wide reset. (1)APEX 20KE devices have four dedicated clocks. (2)

## Single-Port Mode

The APEX 20K ESB also supports a single-port mode, which is used when simultaneous reads and writes are not required. See Figure 22.

#### Altera Corporation



#### Figure 22. ESB in Single-Port Mode Note (1)

#### Notes to Figure 22:

All registers can be asynchronously cleared by ESB local interconnect signals, global signals, or the chip-wide reset.
APEX 20KE devices have four dedicated clocks.

## **Content-Addressable Memory**

In APEX 20KE devices, the ESB can implement CAM. CAM can be thought of as the inverse of RAM. When read, RAM outputs the data for a given address. Conversely, CAM outputs an address for a given data word. For example, if the data FA12 is stored in address 14, the CAM outputs 14 when FA12 is driven into it.

CAM is used for high-speed search operations. When searching for data within a RAM block, the search is performed serially. Thus, finding a particular data word can take many cycles. CAM searches all addresses in parallel and outputs the address storing a particular word. When a match is found, a match flag is set high. Figure 23 shows the CAM block diagram.

For designs that require both a multiplied and non-multiplied clock, the clock trace on the board can be connected to CLK2p. Table 14 shows the combinations supported by the ClockLock and ClockBoost circuitry. The CLK2p pin can feed both the ClockLock and ClockBoost circuitry in the APEX 20K device. However, when both circuits are used, the other clock pin (CLK1p) cannot be used.

Table 14. Multiplication Factor Combinations					
Clock 1 Clock 2					
×1	×1				
×1, ×2	×2				
×1, ×2, ×4	×4				

## APEX 20KE ClockLock Feature

APEX 20KE devices include an enhanced ClockLock feature set. These devices include up to four PLLs, which can be used independently. Two PLLs are designed for either general-purpose use or LVDS use (on devices that support LVDS I/O pins). The remaining two PLLs are designed for general-purpose use. The EP20K200E and smaller devices have two PLLs; the EP20K300E and larger devices have four PLLs.

The following sections describe some of the features offered by the APEX 20KE PLLs.

## External PLL Feedback

The ClockLock circuit's output can be driven off-chip to clock other devices in the system; further, the feedback loop of the PLL can be routed off-chip. This feature allows the designer to exercise fine control over the I/O interface between the APEX 20KE device and another high-speed device, such as SDRAM.

## Clock Multiplication

The APEX 20KE ClockBoost circuit can multiply or divide clocks by a programmable number. The clock can be multiplied by  $m/(n \times k)$  or  $m/(n \times v)$ , where *m* and *k* range from 2 to 160, and *n* and *v* range from 1 to 16. Clock multiplication and division can be used for time-domain multiplexing and other functions, which can reduce design LE requirements.

The APEX 20K device instruction register length is 10 bits. The APEX 20K device USERCODE register length is 32 bits. Tables 20 and 21 show the boundary-scan register length and device IDCODE information for APEX 20K devices.

Table 20. APEX 20K Boundary-Scan Register Length						
Device	Boundary-Scan Register Length					
EP20K30E	420					
EP20K60E	624					
EP20K100	786					
EP20K100E	774					
EP20K160E	984					
EP20K200	1,176					
EP20K200E	1,164					
EP20K300E	1,266					
EP20K400	1,536					
EP20K400E	1,506					
EP20K600E	1,806					
EP20K1000E	2,190					
EP20K1500E	1 (1)					

#### Note to Table 20:

(1) This device does not support JTAG boundary scan testing.

Table 22 shows the JTAG timing parameters and values for APEX 20K devices.

Table 22. AFEX 20K JTAG TIIIIIIY Falaineleis & Values							
Symbol	Parameter	Min	Max	Unit			
t <sub>JCP</sub>	TCK clock period	100		ns			
t <sub>JCH</sub>	TCK clock high time	50		ns			
t <sub>JCL</sub>	TCK clock low time	50		ns			
t <sub>JPSU</sub>	JTAG port setup time	20		ns			
t <sub>JPH</sub>	JTAG port hold time	45		ns			
t <sub>JPCO</sub>	JTAG port clock to output		25	ns			
t <sub>JPZX</sub>	JTAG port high impedance to valid output		25	ns			
t <sub>JPXZ</sub>	JTAG port valid output to high impedance		25	ns			
t <sub>JSSU</sub>	Capture register setup time	20		ns			
t <sub>JSH</sub>	Capture register hold time	45		ns			
t <sub>JSCO</sub>	Update register clock to output		35	ns			
t <sub>JSZX</sub>	Update register high impedance to valid output		35	ns			
t <sub>JSXZ</sub>	Update register valid output to high impedance		35	ns			

Table 22. APEX 20K JTAG Timing Parameters & Values

For more information, see the following documents:

- Application Note 39 (IEEE Std. 1149.1 (JTAG) Boundary-Scan Testing in Altera Devices)
- Jam Programming & Test Language Specification

## **Generic Testing**

Each APEX 20K device is functionally tested. Complete testing of each configurable static random access memory (SRAM) bit and all logic functionality ensures 100% yield. AC test measurements for APEX 20K devices are made under conditions equivalent to those shown in Figure 32. Multiple test patterns can be used to configure devices during all stages of the production flow.

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For DC Operating Specifications on APEX 20KE I/O standards, please refer to *Application Note 117 (Using Selectable I/O Standards in Altera Devices).* 

Table 30. APEX 20KE Device Capacitance Note (15)							
Symbol	Parameter	Conditions	Min	Max	Unit		
C <sub>IN</sub>	Input capacitance	V <sub>IN</sub> = 0 V, f = 1.0 MHz		8	pF		
CINCLK	Input capacitance on dedicated clock pin	V <sub>IN</sub> = 0 V, f = 1.0 MHz		12	pF		
C <sub>OUT</sub>	Output capacitance	V <sub>OUT</sub> = 0 V, f = 1.0 MHz		8	pF		

#### Notes to Tables 27 through 30:

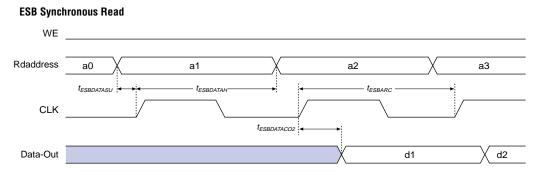
- (1) See the Operating Requirements for Altera Devices Data Sheet.
- (2) Minimum DC input is -0.5 V. During transitions, the inputs may undershoot to -2.0 V or overshoot to 5.75 V for input currents less than 100 mA and periods shorter than 20 ns.
- (3) Numbers in parentheses are for industrial-temperature-range devices.
- (4) Maximum  $V_{CC}$  rise time is 100 ms, and  $V_{CC}$  must rise monotonically.
- (5) Minimum DC input is -0.5 V. During transitions, the inputs may undershoot to -2.0 V or overshoot to the voltage shown in the following table based on input duty cycle for input currents less than 100 mA. The overshoot is dependent upon duty cycle of the signal. The DC case is equivalent to 100% duty cycle.

Vin	Max. Duty Cycle
4.0V	100% (DC)
4.1	90%

- 4.2 50%
- 4.3 30%
- 4.4 17%
- 4.5 10%
- (6) All pins, including dedicated inputs, clock, I/O, and JTAG pins, may be driven before V<sub>CCINT</sub> and V<sub>CCIO</sub> are powered.
- (7) Typical values are for  $T_A = 25^\circ$  C,  $V_{CCINT} = 1.8$  V, and  $V_{CCIO} = 1.8$  V, 2.5 V or 3.3 V.
- (8) These values are specified under the APEX 20KE device recommended operating conditions, shown in Table 24 on page 60.
- (9) Refer to Application Note 117 (Using Selectable I/O Standards in Altera Devices) for the V<sub>IH</sub>, V<sub>IL</sub>, V<sub>OH</sub>, V<sub>OL</sub>, and I<sub>I</sub> parameters when VCCIO = 1.8 V.
- (10) The APEX 20KE input buffers are compatible with 1.8-V, 2.5-V and 3.3-V (LVTTL and LVCMOS) signals. Additionally, the input buffers are 3.3-V PCI compliant. Input buffers also meet specifications for GTL+, CTT, AGP, SSTL-2, SSTL-3, and HSTL.
- (11) The I<sub>OH</sub> parameter refers to high-level TTL, PCI, or CMOS output current.
- (12) The I<sub>OL</sub> parameter refers to low-level TTL, PCI, or CMOS output current. This parameter applies to open-drain pins as well as output pins.
- (13) This value is specified for normal device operation. The value may vary during power-up.
- (14) Pin pull-up resistance values will be lower if an external source drives the pin higher than V<sub>CCIO</sub>.
- (15) Capacitance is sample-tested only.

Figure 33 shows the relationship between  $\rm V_{CCIO}$  and  $\rm V_{CCINT}$  for 3.3-V PCI compliance on APEX 20K devices.

Figure 39. ESB Synchronous Timing Waveforms



#### ESB Synchronous Write (ESB Output Registers Used)

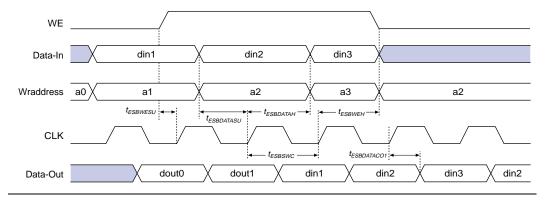


Figure 40 shows the timing model for bidirectional I/O pin timing.

Symbol	-1 Spee	d Grade	-2 Speed Grade		-3 Speed Grade		Units
					_		
	Min	Max	Min	Max	Min	Max	
t <sub>SU</sub>	0.1		0.3		0.6		ns
t <sub>H</sub>	0.5		0.8		0.9		ns
t <sub>CO</sub>		0.1		0.4		0.6	ns
t <sub>LUT</sub>		1.0		1.2		1.4	ns
t <sub>ESBRC</sub>		1.7		2.1		2.4	ns
t <sub>ESBWC</sub>		5.7		6.9		8.1	ns
t <sub>ESBWESU</sub>	3.3		3.9		4.6		ns
t <sub>ESBDATASU</sub>	2.2		2.7		3.1		ns
t <sub>ESBDATAH</sub>	0.6		0.8		0.9		ns
t <sub>ESBADDRSU</sub>	2.4		2.9		3.3		ns
t <sub>ESBDATACO1</sub>		1.3		1.6		1.8	ns
t <sub>ESBDATACO2</sub>		2.5		3.1		3.6	ns
t <sub>ESBDD</sub>		2.5		3.3		3.6	ns
t <sub>PD</sub>		2.5		3.1		3.6	ns
t <sub>PTERMSU</sub>	1.7		2.1		2.4		ns
t <sub>PTERMCO</sub>		1.0		1.2		1.4	ns
t <sub>F1-4</sub>		0.4		0.5		0.6	ns
t <sub>F5-20</sub>		2.6		2.8		2.9	ns
t <sub>F20+</sub>		3.7		3.8		3.9	ns
t <sub>CH</sub>	2.0		2.5		3.0		ns
t <sub>CL</sub>	2.0		2.5		3.0		ns
t <sub>CLRP</sub>	0.5		0.6		0.8		ns
t <sub>PREP</sub>	0.5		0.5		0.5		ns
t <sub>ESBCH</sub>	2.0		2.5		3.0		ns
t <sub>ESBCL</sub>	2.0		2.5		3.0		ns
t <sub>ESBWP</sub>	1.5		1.9		2.2		ns
t <sub>ESBRP</sub>	1.0		1.2		1.4		ns

Tables 43 through 48 show the I/O external and external bidirectional timing parameter values for EP20K100, EP20K200, and EP20K400 APEX 20K devices.

Symbol	-1 Speed Grade		-2 Speed Grade		-3 Speed Grade		Unit
	Min	Max	Min	Мах	Min	Мах	
t <sub>INSU</sub> (1)	2.3		2.8		3.2		ns
t <sub>INH</sub> (1)	0.0		0.0		0.0		ns
t <sub>OUTCO</sub> (1)	2.0	4.5	2.0	4.9	2.0	6.6	ns
t <sub>INSU</sub> (2)	1.1		1.2		-		ns
t <sub>INH</sub> (2)	0.0		0.0		-		ns
t <sub>оитсо</sub> <i>(2)</i>	0.5	2.7	0.5	3.1	_	4.8	ns

Table 44. EP20K100 External Bidirectional Timing Parameters									
Symbol	-1 Speed Grade		-2 Speed Grade		-3 Speed Grade		Unit		
	Min	Max	Min	Max	Min	Max			
t <sub>INSUBIDIR</sub> (1)	2.3		2.8		3.2		ns		
t <sub>INHBIDIR</sub> (1)	0.0		0.0		0.0		ns		
toutcobidir (1)	2.0	4.5	2.0	4.9	2.0	6.6	ns		
t <sub>XZBIDIR</sub> (1)		5.0		5.9		6.9	ns		
t <sub>ZXBIDIR</sub> (1)		5.0		5.9		6.9	ns		
t <sub>insubidir</sub> (2)	1.0		1.2		-		ns		
t <sub>INHBIDIR</sub> (2)	0.0		0.0		-		ns		
toutcobidir (2)	0.5	2.7	0.5	3.1	-	-	ns		
t <sub>XZBIDIR</sub> (2)		4.3		5.0		-	ns		
t <sub>ZXBIDIR</sub> (2)		4.3		5.0		-	ns		

Table 45. EP20K200 External Timing Parameters									
Symbol	-1 Spee	-1 Speed Grade		-2 Speed Grade		-3 Speed Grade			
	Min	Max	Min	Max	Min	Max	-		
t <sub>INSU</sub> (1)	1.9		2.3		2.6		ns		
t <sub>INH</sub> (1)	0.0		0.0		0.0		ns		
t <sub>OUTCO</sub> (1)	2.0	4.6	2.0	5.6	2.0	6.8	ns		
t <sub>INSU</sub> (2)	1.1		1.2		-		ns		
t <sub>INH</sub> (2)	0.0		0.0		-		ns		
t <sub>оитсо</sub> <i>(2)</i>	0.5	2.7	0.5	3.1	-	-	ns		

Symbol	-	1	-	-2	-3		Unit
	Min	Max	Min	Max	Min	Max	
t <sub>ESBARC</sub>		1.65		2.02		2.11	ns
t <sub>ESBSRC</sub>		2.21		2.70		3.11	ns
t <sub>ESBAWC</sub>		3.04		3.79		4.42	ns
t <sub>ESBSWC</sub>		2.81		3.56		4.10	ns
t <sub>ESBWASU</sub>	0.54		0.66		0.73		ns
t <sub>ESBWAH</sub>	0.36		0.45		0.47		ns
t <sub>ESBWDSU</sub>	0.68		0.81		0.94		ns
t <sub>ESBWDH</sub>	0.36		0.45		0.47		ns
t <sub>ESBRASU</sub>	1.58		1.87		2.06		ns
t <sub>ESBRAH</sub>	0.00		0.00		0.01		ns
t <sub>ESBWESU</sub>	1.41		1.71		2.00		ns
t <sub>ESBWEH</sub>	0.00		0.00		0.00		ns
t <sub>ESBDATASU</sub>	-0.02		-0.03		0.09		ns
t <sub>ESBDATAH</sub>	0.13		0.13		0.13		ns
t <sub>ESBWADDRSU</sub>	0.14		0.17		0.35		ns
t <sub>ESBRADDRSU</sub>	0.21		0.27		0.43		ns
t <sub>ESBDATACO1</sub>		1.04		1.30		1.46	ns
t <sub>ESBDATACO2</sub>		2.15		2.70		3.16	ns
t <sub>ESBDD</sub>		2.69		3.35		3.97	ns
t <sub>PD</sub>		1.55		1.93		2.29	ns
t <sub>PTERMSU</sub>	1.01		1.23		1.52		ns
t <sub>PTERMCO</sub>		1.06		1.32		1.04	ns

Symbol	-	1	-	-2		3	Unit
	Min	Max	Min	Мах	Min	Max	
t <sub>insubidir</sub>	2.86		3.24		3.54		ns
t <sub>inhbidir</sub>	0.00		0.00		0.00		ns
t <sub>outcobidir</sub>	2.00	5.07	2.00	5.59	2.00	6.13	ns
t <sub>xzbidir</sub>		7.43		8.23		8.58	ns
tzxbidir		7.43		8.23		8.58	ns
t <sub>insubidirpll</sub>	4.93		5.48		-		ns
t <sub>inhbidirpll</sub>	0.00		0.00		-		ns
toutcobidirpll	0.50	3.00	0.50	3.35	-	-	ns
t <sub>XZBIDIRPLL</sub>		5.36		5.99		-	ns
t <sub>ZXBIDIRPLL</sub>		5.36		5.99		-	ns

Tables 73 through 78 describe  $f_{MAX}$  LE Timing Microparameters,  $f_{MAX}$  ESB Timing Microparameters,  $f_{MAX}$  Routing Delays, Minimum Pulse Width Timing Parameters, External Timing Parameters, and External Bidirectional Timing Parameters for EP20K200E APEX 20KE devices.

Table 73. EP2	Table 73. EP20K200E f <sub>MAX</sub> LE Timing Microparameters								
Symbol	-1		-2		-3		Unit		
	Min	Max	Min	Max	Min	Мах			
t <sub>SU</sub>	0.23		0.24		0.26		ns		
t <sub>H</sub>	0.23		0.24		0.26		ns		
t <sub>CO</sub>		0.26		0.31		0.36	ns		
t <sub>LUT</sub>		0.70		0.90		1.14	ns		

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Symbol	-1 Speed Grade		-2 Speed Grade		-3 Speed Grade		Unit
	Min	Max	Min	Max	Min	Max	1
t <sub>ESBARC</sub>		1.67		1.91		1.99	ns
t <sub>ESBSRC</sub>		2.30		2.66		2.93	ns
t <sub>ESBAWC</sub>		3.09		3.58		3.99	ns
t <sub>ESBSWC</sub>		3.01		3.65		4.05	ns
t <sub>ESBWASU</sub>	0.54		0.63		0.65		ns
t <sub>ESBWAH</sub>	0.36		0.43		0.42		ns
t <sub>ESBWDSU</sub>	0.69		0.77		0.84		ns
t <sub>ESBWDH</sub>	0.36		0.43		0.42		ns
t <sub>ESBRASU</sub>	1.61		1.77		1.86		ns
t <sub>ESBRAH</sub>	0.00		0.00		0.01		ns
t <sub>ESBWESU</sub>	1.35		1.47		1.61		ns
t <sub>ESBWEH</sub>	0.00		0.00		0.00		ns
t <sub>ESBDATASU</sub>	-0.18		-0.30		-0.27		ns
t <sub>ESBDATAH</sub>	0.13		0.13		0.13		ns
t <sub>ESBWADDRSU</sub>	-0.02		-0.11		-0.03		ns
t <sub>ESBRADDRSU</sub>	0.06		-0.01		-0.05		ns
t <sub>ESBDATACO1</sub>		1.16		1.40		1.54	ns
t <sub>ESBDATACO2</sub>		2.18		2.55		2.85	ns
t <sub>ESBDD</sub>		2.73		3.17		3.58	ns
t <sub>PD</sub>		1.57		1.83		2.07	ns
t <sub>PTERMSU</sub>	0.92		0.99		1.18		ns
t <sub>PTERMCO</sub>		1.18		1.43		1.17	ns

Symbol	-1 Speed Grade		-2 Speed Grade		-3 Speed Grade		Unit
	Min	Max	Min	Max	Min	Max	1
t <sub>CH</sub>	2.00		2.50		2.75		ns
t <sub>CL</sub>	2.00		2.50		2.75		ns
t <sub>CLRP</sub>	0.18		0.26		0.34		ns
t <sub>PREP</sub>	0.18		0.26		0.34		ns
t <sub>ESBCH</sub>	2.00		2.50		2.75		ns
t <sub>ESBCL</sub>	2.00		2.50		2.75		ns
t <sub>ESBWP</sub>	1.17		1.68		2.18		ns
t <sub>ESBRP</sub>	0.95		1.35		1.76		ns

Symbol	-1 Speed Grade		-2 Speed Grade		-3 Speed Grade		Unit
	Min	Max	Min	Max	Min	Max	
t <sub>INSU</sub>	2.74		2.74		2.87		ns
t <sub>INH</sub>	0.00		0.00		0.00		ns
toutco	2.00	5.51	2.00	6.06	2.00	6.61	ns
tINSUPLL	1.86		1.96		-		ns
t <sub>INHPLL</sub>	0.00		0.00		-		ns
toutcopll	0.50	2.62	0.50	2.91	-	-	ns

Symbol	-1 Speed Grade		-2 Speed Grade		-3 Speed Grade		Unit
	Min	Max	Min	Max	Min	Max	1
t <sub>insubidir</sub>	0.64		0.98		1.08		ns
t <sub>inhbidir</sub>	0.00		0.00		0.00		ns
toutcobidir	2.00	5.51	2.00	6.06	2.00	6.61	ns
t <sub>xzbidir</sub>		6.10		6.74		7.10	ns
t <sub>zxbidir</sub>		6.10		6.74		7.10	ns
t <sub>insubidirpll</sub>	2.26		2.68		-		ns
t <sub>inhbidirpll</sub>	0.00		0.00		-		ns
toutcobidirpll	0.50	2.62	0.50	2.91	-	-	ns
t <sub>xzbidirpll</sub>		3.21		3.59		-	ns
t <sub>ZXBIDIRPLL</sub>		3.21		3.59		-	ns

## Version 4.1

APEX 20K Programmable Logic Device Family Data Sheet version 4.1 contains the following changes:

- *t*<sub>ESBWEH</sub> added to Figure 37 and Tables 35, 50, 56, 62, 68, 74, 86, 92, 97, and 104.
- Updated EP20K300E device internal and external timing numbers in Tables 79 through 84.



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